



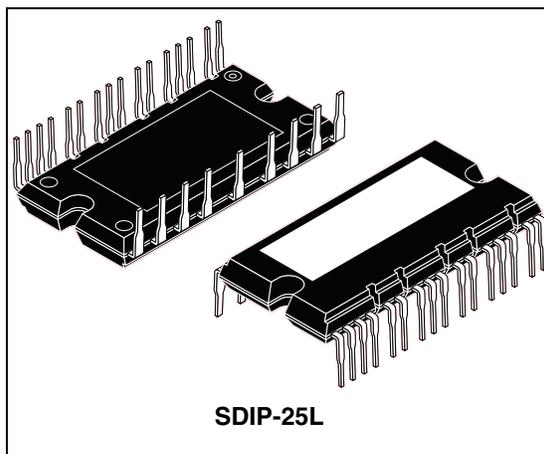
# STGIPS10K60A

SLLIMM™

small low-loss intelligent molded module

## Features

- IPM 10 A, 600 V, 3-phase IGBT inverter bridge including control ICs for gate driving and free-wheeling diodes
- Short-circuit rugged IGBT
- $V_{CE(sat)}$  negative temperature coefficient
- 3.3 V, 5 V, 15 V CMOS/TTL inputs comparators with hysteresis and pull down resistor
- Under-voltage lockout
- Internal bootstrap diode
- Interlocking function
- DBC substrate leading to low thermal resistance
- Isolation rating of 2500 Vrms/min.
- 5 k $\Omega$  NTC thermistor for temperature control



## Applications

- 3-phase inverters for motor drives
- Home appliances, such as washing machines, refrigerators, air conditioners

## Description

This intelligent power module provides a compact, high performance AC motor drive in a simple, rugged design. Combining ST proprietary control ICs with the most advanced short-circuit-rugged IGBT system technology, this device is ideal for 3-phase inverters in applications such as home appliances and air conditioners. SLLIMM™ is a trademark of STMicroelectronics.

**Table 1. Device summary**

Order code	Marking	Package	Packaging
STGIPS10K60A	GIPS10K60A	SDIP-25L	Tube

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# 1 Internal block diagram and pin configuration

Figure 1. Internal block diagram

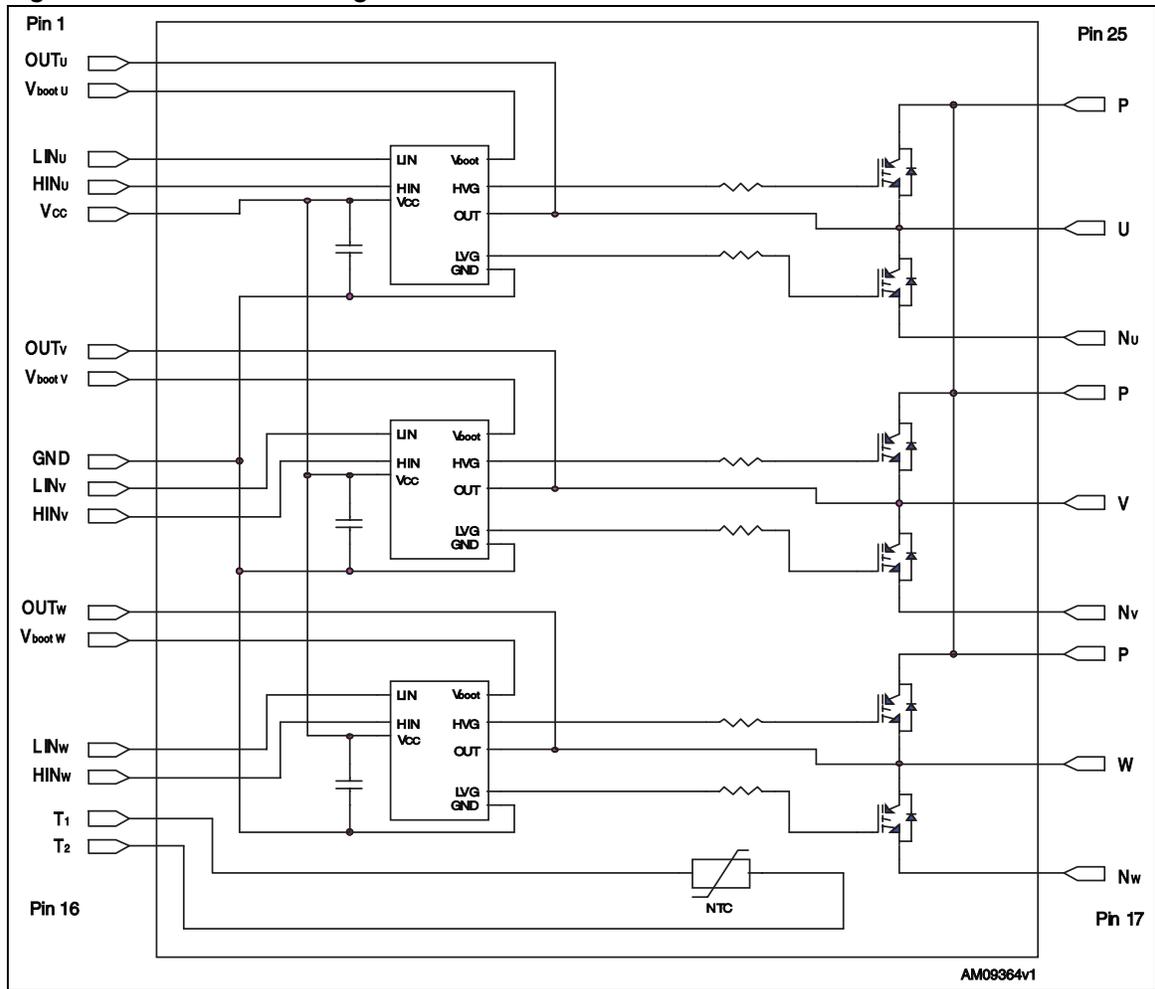
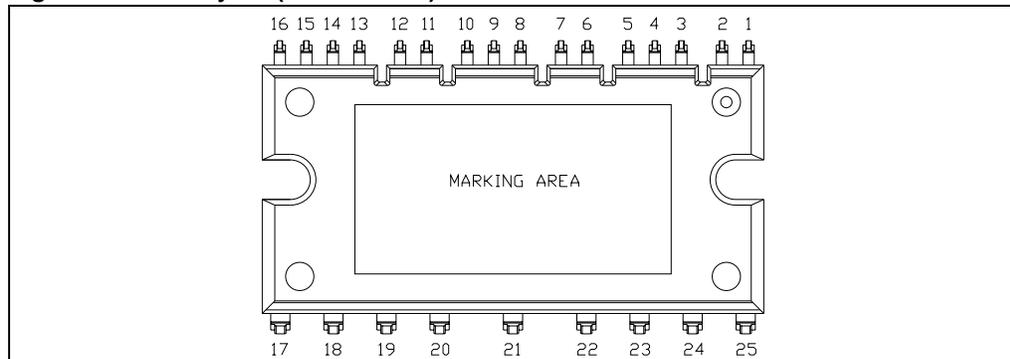


Table 2. Pin description

Pin	Symbol	Description
1	OUT <sub>U</sub>	High side reference output for U phase
2	V <sub>boot U</sub>	Bootstrap voltage for U phase
3	LIN <sub>U</sub>	Low side logic input for U phase
4	HIN <sub>U</sub>	High side logic input for U phase
5	V <sub>CC</sub>	Low voltage power supply
6	OUT <sub>V</sub>	High side reference output for V phase
7	V <sub>boot V</sub>	Bootstrap voltage for V phase
8	GND	Ground
9	LIN <sub>V</sub>	Low side logic input for V phase
10	HIN <sub>V</sub>	High side logic input for V phase
11	OUT <sub>W</sub>	High side reference output for W phase
12	V <sub>boot W</sub>	Bootstrap voltage for W phase
13	LIN <sub>W</sub>	Low side logic input for W phase
14	HIN <sub>W</sub>	High side logic input for W phase
15	T <sub>1</sub>	NTC thermistor terminal 1
16	T <sub>2</sub>	NTC thermistor terminal 2
17	N <sub>W</sub>	Negative DC input for W phase
18	W	W phase output
19	P	Positive DC input
20	N <sub>V</sub>	Negative DC input for V phase
21	V	V phase output
22	P	Positive DC input
23	N <sub>U</sub>	Negative DC input for U phase
24	U	U phase output
25	P	Positive DC input

Figure 2. Pin layout (bottom view)



## 2 Electrical ratings

### 2.1 Absolute maximum ratings

**Table 3. Inverter part**

Symbol	Parameter	Value	Unit
$V_{PN}$	Supply voltage applied between P - N <sub>U</sub> , N <sub>V</sub> , N <sub>W</sub>	450	V
$V_{PN(surge)}$	Supply voltage (surge) applied between P - N <sub>U</sub> , N <sub>V</sub> , N <sub>W</sub>	500	V
$V_{CES}$	Each IGBT collector emitter voltage ( $V_{IN}^{(1)} = 0$ )	600	V
$\pm I_C^{(2)}$	Each IGBT continuous collector current at $T_C = 25^\circ\text{C}$	10	A
$\pm I_{CP}^{(3)}$	Each IGBT pulsed collector current	20	A
$P_{TOT}$	Each IGBT total dissipation at $T_C = 25^\circ\text{C}$	33	W
$t_{scw}$	Short-circuit withstand time, $V_{CE} = 0.5 V_{(BR)CES}$ $T_j = 125^\circ\text{C}$ , $V_{CC} = V_{boot} = 15\text{ V}$ , $V_{IN}^{(1)} = 5\text{ V}$	5	$\mu\text{s}$

1. Applied between HIN<sub>i</sub>, LIN<sub>i</sub> and GND for i = U, V, W.
2. Calculated according to the iterative formula:

$$I_C(T_C) = \frac{T_{j(max)} - T_C}{R_{thj-c} \times V_{CE(sat)(max)}(T_{j(max)}, I_C(T_C))}$$

3. Pulse width limited by max junction temperature.

**Table 4. Control part**

Symbol	Parameter	Value	Unit
$V_{OUT}$	Output voltage applied between OUT <sub>U</sub> , OUT <sub>V</sub> , OUT <sub>W</sub> - GND ( $V_{CC} = 15\text{ V}$ )	-3 to $V_{boot} - 18$	V
$V_{CC}$	Low voltage power supply	-0.3 to +18	V
$V_{boot}$	Bootstrap voltage applied between $V_{boot i} - OUT_i$ for i = U, V, W	-1 to 618	V
$V_{IN}$	Logic input voltage applied between HIN <sub>i</sub> , LIN <sub>i</sub> and GND for i = U, V, W	-0.3 to $V_{CC} + 0.3$	V
$dV_{out}/dt$	Allowed output slew rate	50	V/ns

**Table 5. Total system**

Symbol	Parameter	Value	Unit
$V_{ISO}$	Isolation withstand voltage applied between each pin and heatsink plate (AC voltage, $t = 60\text{sec.}$ )	2500	V
$T_J^{(1)}$	Operating junction temperature	-40 to 150	°C
$T_C$	Module case operating temperature	-40 to 125	°C

1. The maximum junction temperature rating of the power chips integrated within the SDIP module is 150 °C (@ $T_C \leq 100$  °C). To ensure safe operation of the SDIP module, the average junction temperature should be limited to  $T_{J(\text{avg})} \leq 125$  °C (@ $T_C \leq 100$  °C).

## 2.2 Thermal data

**Table 6. Thermal data**

Symbol	Parameter	Value	Unit
$R_{thJC}$	Thermal resistance junction-case single IGBT max.	3.8	°C/W
	Thermal resistance junction-case single diode max.	5.5	°C/W

### 3 Electrical characteristics

$T_j = 25^\circ\text{C}$  unless otherwise specified.

**Table 7. Inverter part**

Symbol	Parameter	Test conditions	Value			Unit
			Min.	Typ.	Max.	
$V_{CE(sat)}$	Collector-emitter saturation voltage	$V_{CC} = V_{boot} = 15\text{ V}$ , $V_{IN}^{(1)} = 5\text{ V}$ , $I_C = 5\text{ A}$	-	2.1	2.5	V
		$V_{CC} = V_{boot} = 15\text{ V}$ , $V_{IN}^{(1)} = 5\text{ V}$ , $I_C = 5\text{ A}$ , $T_j = 125^\circ\text{C}$	-	1.8		
$I_{CES}$	Collector-cut off current ( $V_{IN}^{(1)} = 0$ "logic state")	$V_{CE} = 600\text{ V}$ $V_{CC} = V_{boot} = 15\text{ V}$	-		150	$\mu\text{A}$
$V_F$	Diode forward voltage	$V_{IN}^{(1)} = 0$ "logic state", $I_C = 5\text{ A}$	-		1.9	V
<b>Inductive load switching time and energy</b>						
$t_{on}$	Turn-on time	$V_{DD} = 300\text{ V}$ , $V_{CC} = V_{boot} = 15\text{ V}$ , $V_{IN}^{(1)} = 0 \div 5\text{ V}$ , $I_C = 5\text{ A}$ (see <a href="#">Figure 4</a> )	-	320	-	ns
$t_{c(on)}$	Crossover time (on)		-	70	-	
$t_{off}$	Turn-off time		-	430	-	
$t_{c(off)}$	Crossover time (off)		-	135	-	
$t_{rr}$	Reverse recovery time		-	130	-	
$E_{on}$	Turn-on switching losses		-	65	-	$\mu\text{J}$
$E_{off}$	Turn-off switching losses		-	75	-	

1. Applied between  $HIN_i$ ,  $LIN_i$  and GND for  $i = U, V, W$ .

**Note:**  $t_{ON}$  and  $t_{OFF}$  include the propagation delay time of the internal drive.  $t_{C(ON)}$  and  $t_{C(OFF)}$  are the switching time of IGBT itself under the internally given gate driving condition.

Figure 3. Switching time test circuit

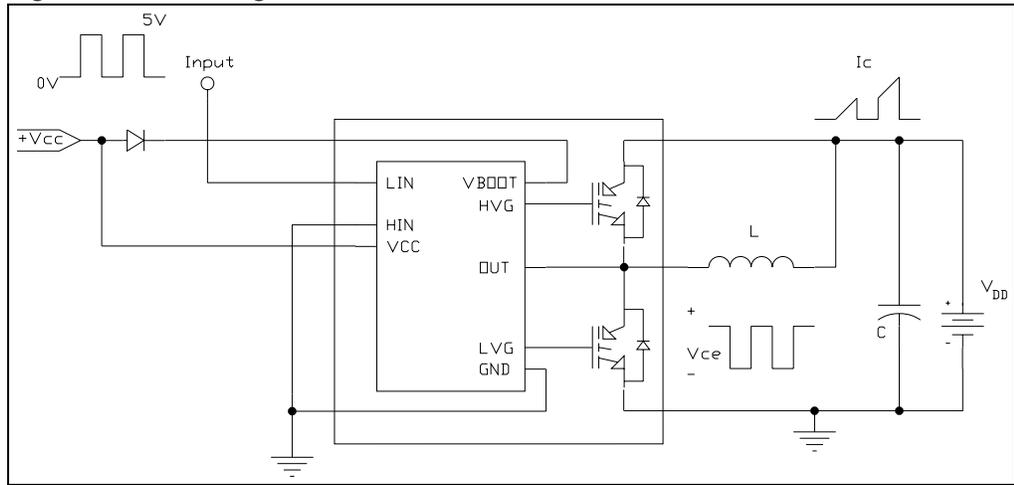
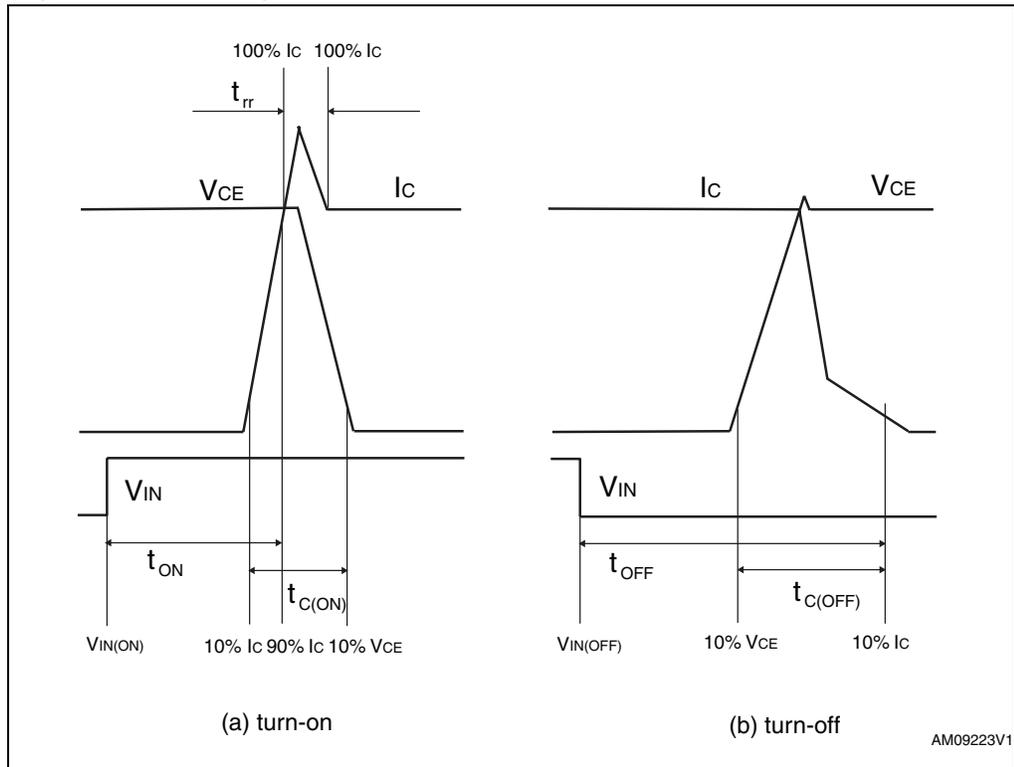


Figure 4. Switching time definition



### 3.1 Control part

**Table 8. Low supply voltage**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{CCth1}$	Under voltage turn on threshold		9.1	9.6	10.1	V
$V_{CCth2}$	Under voltage turn off threshold		7.9	8.3	8.8	V
$V_{CChys}$	Under voltage hystereses		0.9			V
$I_{qccu}$	Under voltage quiescent supply current	$V_{CC} < 9\text{ V}$		0.75	1.2	mA
$I_{qcc}$	Quiescent current	$V_{CC} = 15\text{ V}$		1	1.5	mA

**Table 9. Bootstrap supply**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{boot1}$	Under voltage turn on threshold		8.5	9.5	10.5	V
$V_{boot2}$	Under voltage turn off threshold		7.2	8.3	9.2	V
$V_{bootHys}$	Under voltage hystereses		0.9			V
$I_{qboot}$	Quiescent current				250	$\mu\text{A}$
$R_{DS(on)}$	Bootstrap driver on resistance	$V_{CC} > 12.5\text{ V}$		125		$\Omega$

**Table 10. Logic input <sup>(1)</sup>**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{il}$	Low level logic input voltage				1.1	V
$V_{ih}$	High level logic input voltage		1.8			V
$I_{il}$	Low level logic input current	$V_{IN}^{(2)} = 0$	-1			$\mu\text{A}$
$I_{ih}$	High level logic input current	$V_{IN}^{(1)} = 15\text{ V}$		20	70	$\mu\text{A}$

1. See [Figure 8: Dead time and interlocking definition](#).
2. Applied between  $HIN_i$ ,  $LIN_i$  and GND for  $i = U, V, W$

### 3.1.1 NTC thermistor

**Table 11. NTC thermistor**

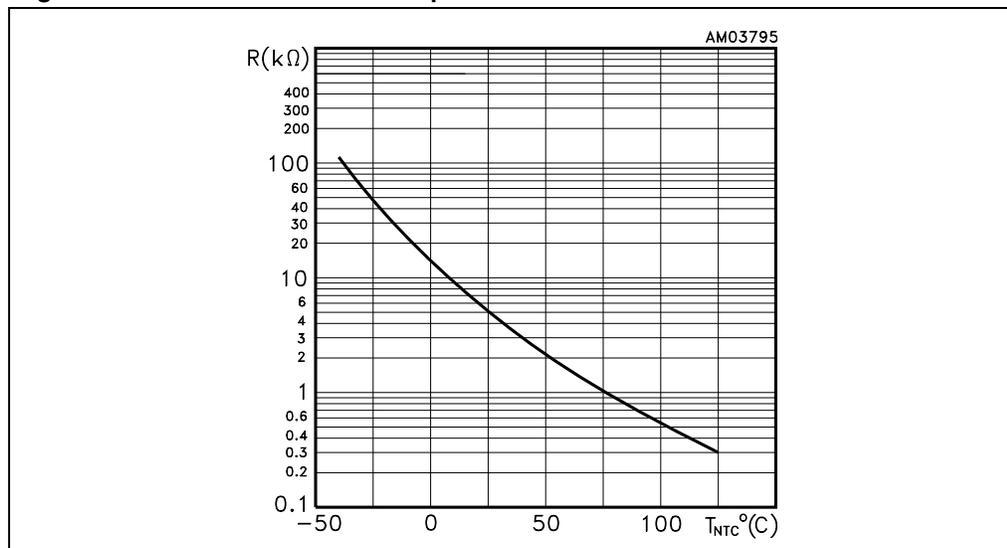
Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit.
R <sub>25</sub>	Resistance	T <sub>C</sub> = 25°C		5		kΩ
R <sub>125</sub>	Resistance	T <sub>C</sub> = 125°C		300		Ω
B	B-constant	T <sub>C</sub> = 25°C		3435		K
T	Operating temperature		-40		125	°C

**Equation 1: resistance variation vs. temperature**

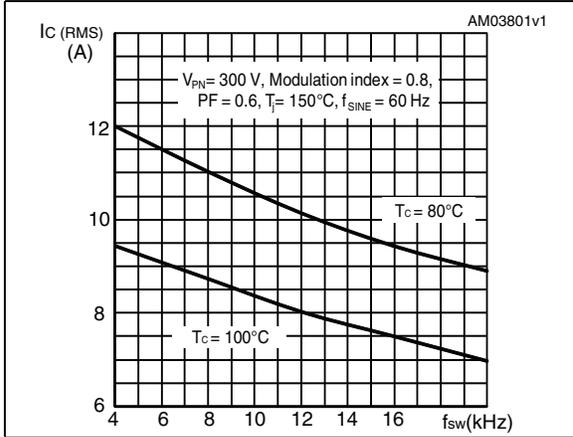
$$R(T) = R_{25} \cdot e^{B \left( \frac{1}{T} - \frac{1}{298} \right)}$$

Where T are temperatures in Kelvins.

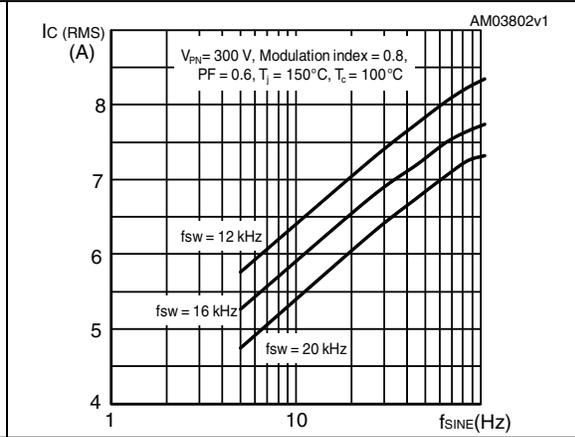
**Figure 5. NTC resistance vs. temperature**



**Figure 6. Maximum  $I_{C(RMS)}$  current vs. switching frequency (1)**

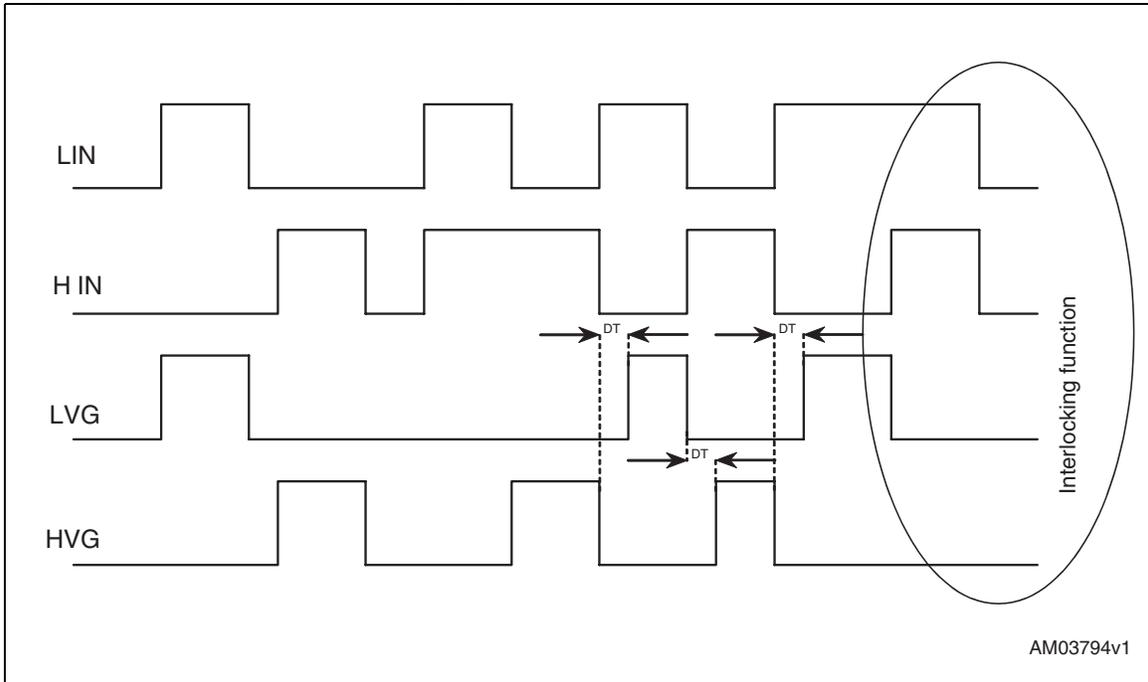


**Figure 7. Maximum  $I_{C(RMS)}$  current vs.  $f_{SINE}$  (1)**



1. Simulated curves refer to typical IGBT parameters and maximum  $R_{thj-c}$ .

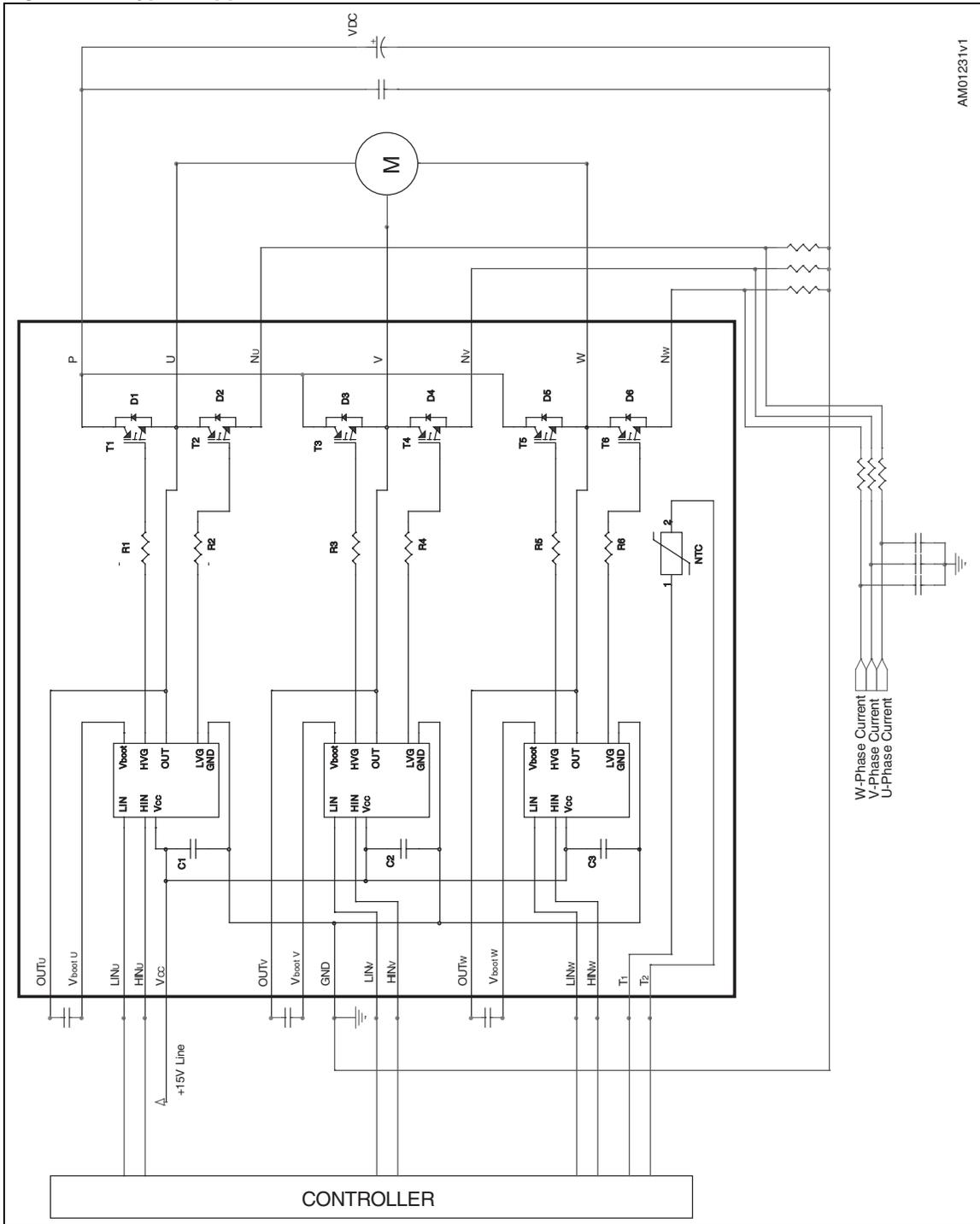
**Figure 8. Dead time and interlocking definition**



Minimum recommended dead time (DT) between low and high side logic input: 1  $\mu\text{s}$ .

# 4 Applications information

Figure 9. Typical application circuit



## 4.1 Recommendations

- Input signal HIN,LIN are active-high logic. A 500 k $\Omega$  (typ.) pull down resistor is built-in for each high side input. If an external RC filter is used, for noise immunity, pay attention to the variation of the input signal level.
- To prevent the input signals oscillation, the wiring of each input should be as short as possible.
- By integrating an application specific type HVIC inside the module, direct coupling to MCU terminals without any opto-coupler is possible.
- Each capacitor should be located as nearby the pins of IPM as possible.
- Low inductance shunt resistors should be used for phase leg current sensing.
- Electrolytic bus capacitors should be mounted as close to the module bus terminals as possible. Additional high frequency ceramic capacitor mounted close to the module pins will further improve performance.

**Table 12. Recommended operating conditions**

Symbol	Parameter	Conditions	Value			Unit
			Min.	Typ.	Max.	
$V_{PN}$	Supply Voltage	Applied between P-Nu, Nv, Nw		300	400	V
$V_{CC}$	Control supply voltage	Applied between $V_{CC}$ -GND	13.5	15	16	V
$V_{BS}$	High side bias voltage	Applied between $V_{BOOTi}$ - $OUT_i$ for $i = U, V, W$	13		16	V
$t_{dead}$	Blanking time to prevent Arm-short	For each input signal	1			$\mu$ s
$f_{PWM}$	PWM input signal	-40°C < $T_c$ < 100°C -40°C < $T_j$ < 125°C			20	kHz

## 5 Package mechanical data

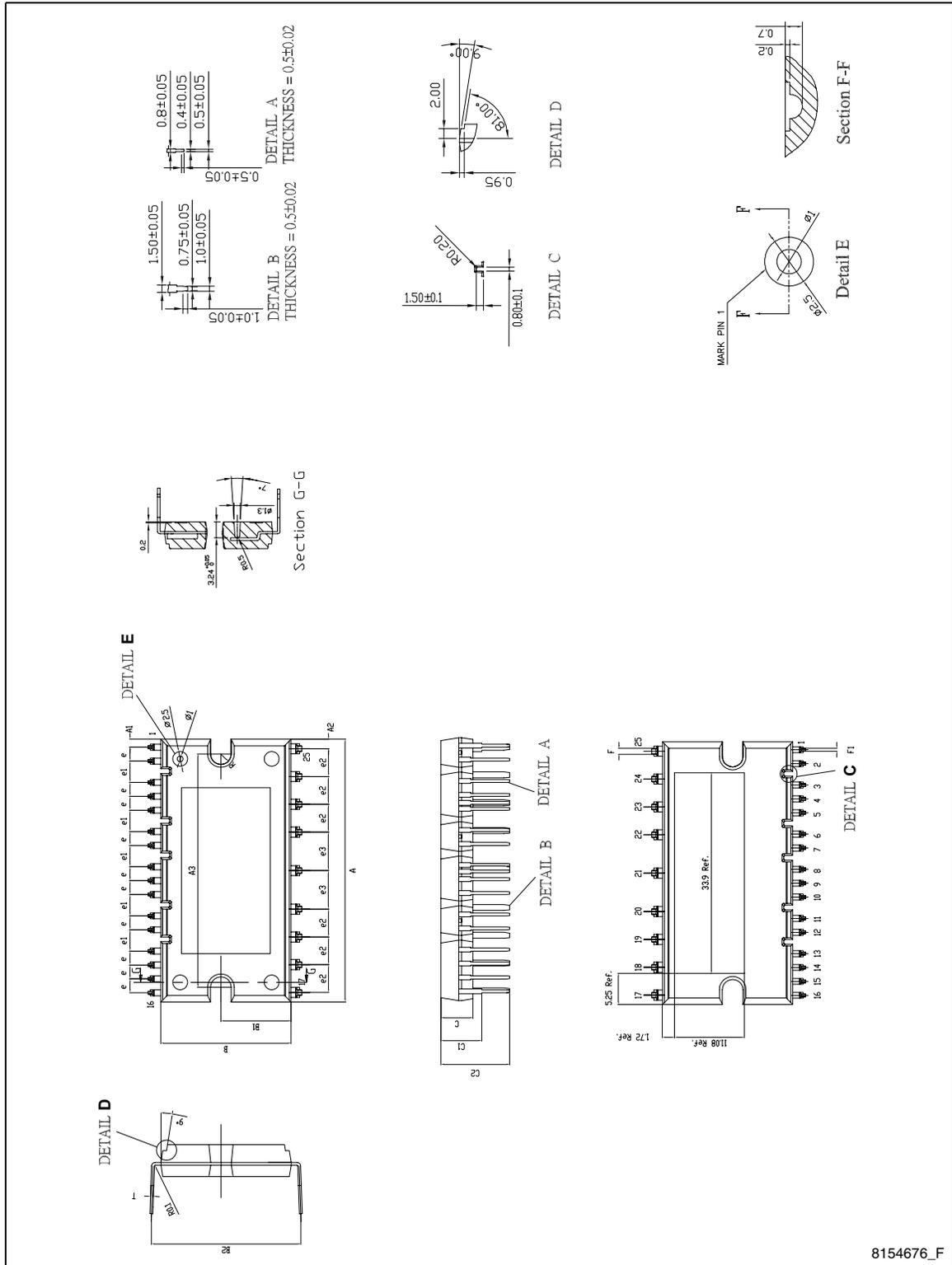
In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK is an ST trademark.

Please refer to dedicated technical note TN0107 for mounting instructions.

**Table 13. SDIP-25L mechanical data**

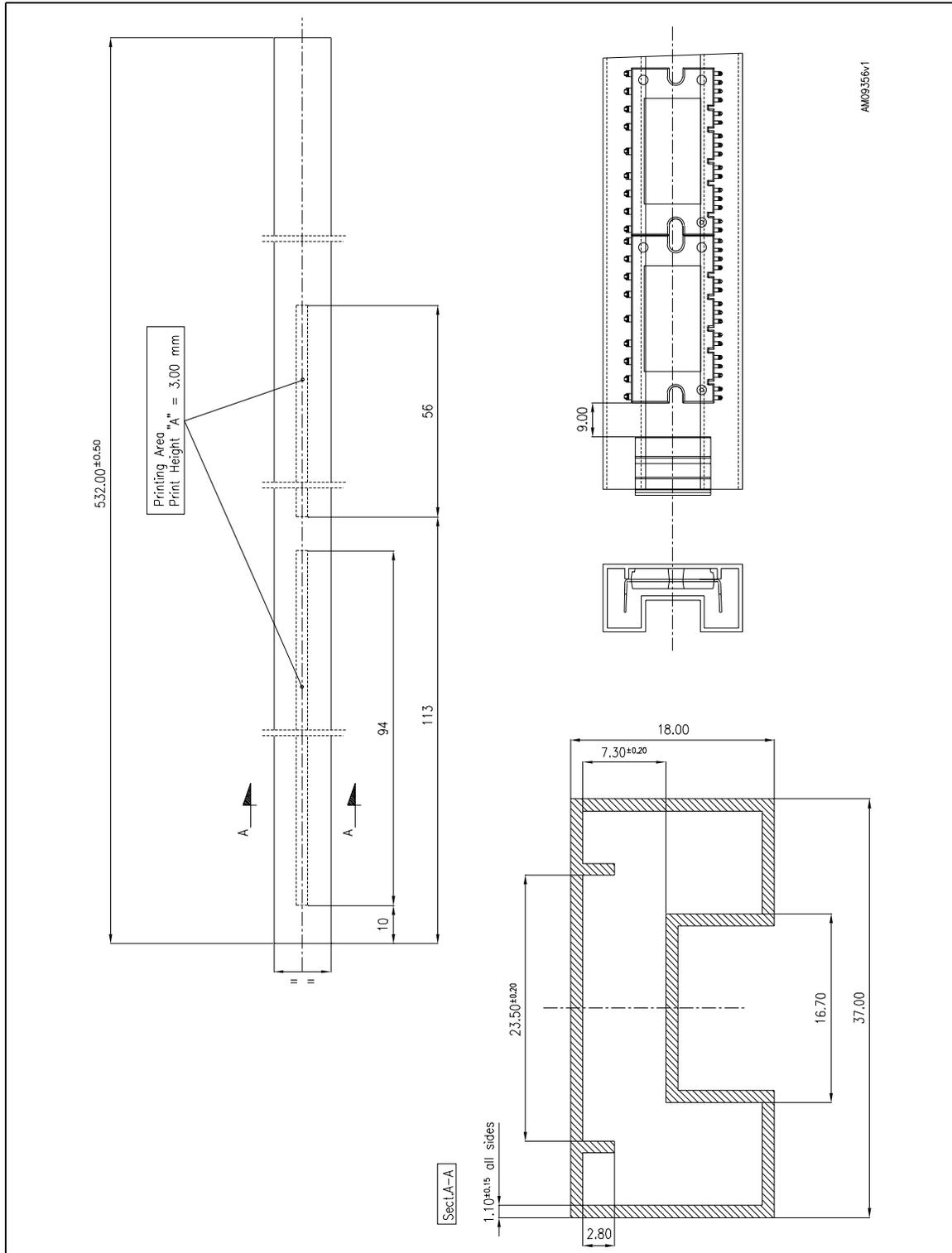
Dim.	(mm.)		
	Min.	Typ.	Max.
A	44		44.8
A1	0.95		1.75
A2	1.2		2
A3	39		39.8
B	21.6		22.4
B1	11.45		12.25
B2	24.83	25.22	25.63
C	5		5.8
C1	6.4		7.4
C2	11.1		12.1
e	1.95	2.35	2.75
e1	3.2	3.6	4
e2	4.3	4.7	5.1
e3	6.1	6.5	6.9
F	0.8	1.0	1.2
F1	0.3	0.5	0.7
R	1.35		2.15
T	0.4	0.55	0.7

Figure 10. SDIP-25L drawing dimensions data



8154676\_F

Figure 11. Packaging specifications of SDIP-25L package



## 6 Revision history

**Table 14. Document revision history**

Date	Revision	Changes
16-Apr-2009	1	Initial release.
11-May-2009	2	Added <a href="#">Figure 6</a> and <a href="#">Figure 7</a> .
17-Jul-2009	3	Reduced $V_{CE(sat)}$ value on <a href="#">Table 7</a> .
06-Apr-2010	4	Document promoted from preliminary data to datasheet. Inserted <a href="#">Figure 3: Switching time test circuit</a> and <a href="#">Table 12: Recommended operating conditions</a> . Updated <a href="#">Table 5: Total system</a> , <a href="#">Table 6: Thermal data</a> , <a href="#">Table 7: Inverter part</a> , <a href="#">Figure 5: NTC resistance vs. temperature</a> , <a href="#">Figure 6: Maximum IC(RMS) current vs. switching frequency</a> , <a href="#">Figure 7: Maximum IC(RMS) current vs. fSINE (1)</a> and <a href="#">Section 5: Package mechanical data</a> .
15-Jun-2010	5	Updated <a href="#">Table 7: Inverter part</a> . Minor text changes to improve readability.
17-Nov-2010	6	Updated <a href="#">Table 3</a> , <a href="#">5</a> , <a href="#">11</a> and <a href="#">12</a> . Modified <a href="#">Figure 6</a> and <a href="#">Figure 7</a> .
07-Mar-2011	7	Updated title with SLLIMM™ in cover page, added SDIP-25L tube dimensions <a href="#">Figure 11 on page 16</a> .

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